Search Notes		

Application/Control No.	Applicant(s)/Patent unde Reexamination		
10/063,884	WANG, CHIEN-FA		
Examiner	Art Unit		
Van Kim T. Nguyen	2151		

SEARCHED			
Class	Subclass	Date	Examiner
709	219	4/29/2005	VN
709	229	4/29/2005	VN
709	230	4/29/2005	VN
709 <sup>°</sup>	233-234	4/29/2005	VN
709	246	4/29/2005	VN
		•	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH	ES STRATEGY	)
	DATE	EXMR
East	4/29/2005	VN
·		